

HS54095

Silicon N Channel MOS FET
High Speed Power Switching

REJ03G1668-0200

Rev.2.00

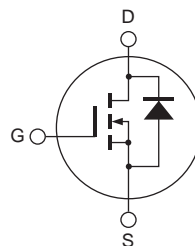
Dec 10, 2009

Features

- Low on-resistance
 $R_{DS(on)} = 13.5 \Omega$ typ. (at $I_D = 0.1$ A, $V_{GS} = 10$ V, $T_a = 25^\circ\text{C}$)
- Low drive current
- High density mounting

Outline

RENESAS Package code: PRSS0003DA-A
(Package name: TO-92(1))



1. Gate
2. Drain
3. Source

Absolute Maximum Ratings

($T_a = 25^\circ\text{C}$)

Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	600	V
Gate to source voltage	V_{GSS}	± 30	V
Drain current	I_D	0.2	A
Drain peak current	$I_{D(pulse)}$ ^{Note1}	0.8	A
Body-drain diode reverse drain current	I_{DR}	0.2	A
Body-drain diode reverse drain peak current	$I_{DR(pulse)}$ ^{Note1}	0.8	A
Channel dissipation	Pch	0.75	W
Channel to ambient thermal impedance	θ_{ch-a}	166.7	$^\circ\text{C/W}$
Channel temperature	Tch	150	$^\circ\text{C}$
Storage temperature	Tstg	-55 to +150	$^\circ\text{C}$

Notes: 1. $PW \leq 10 \mu\text{s}$, duty cycle $\leq 1\%$

Electrical Characteristics

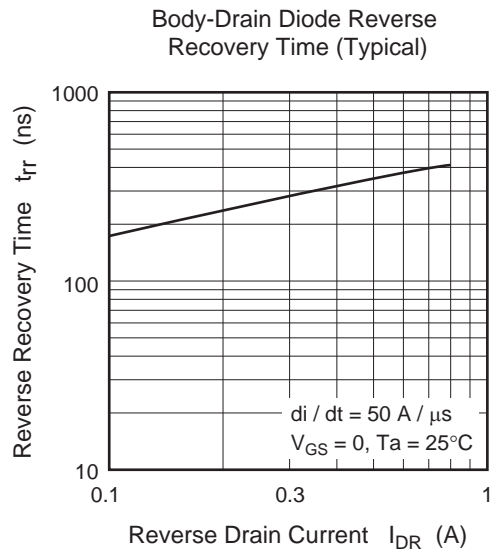
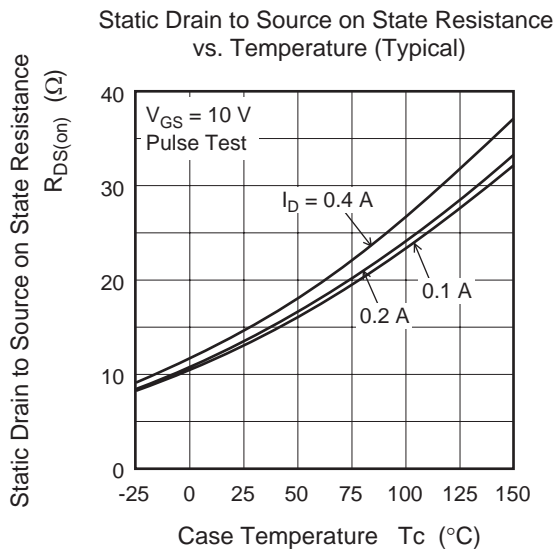
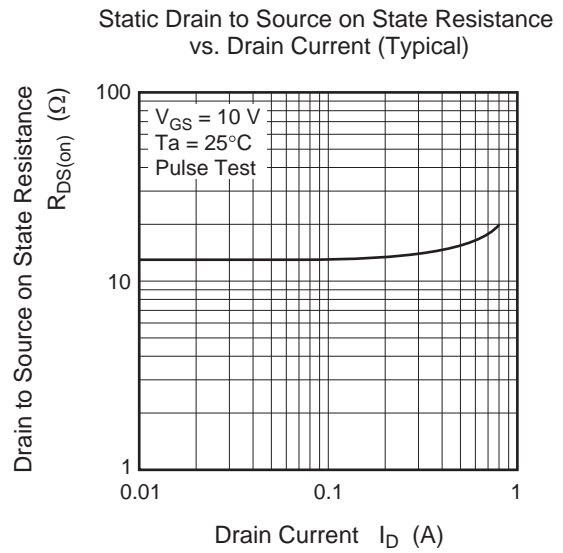
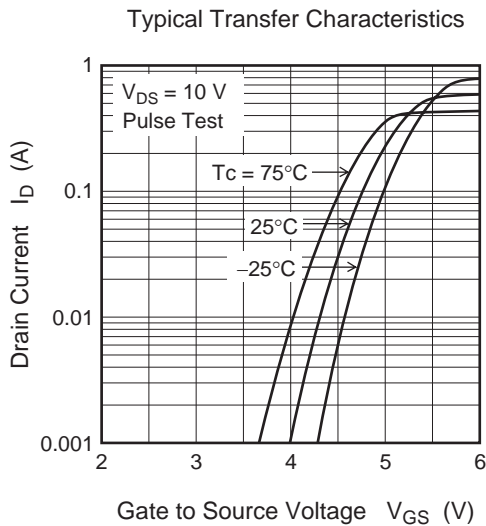
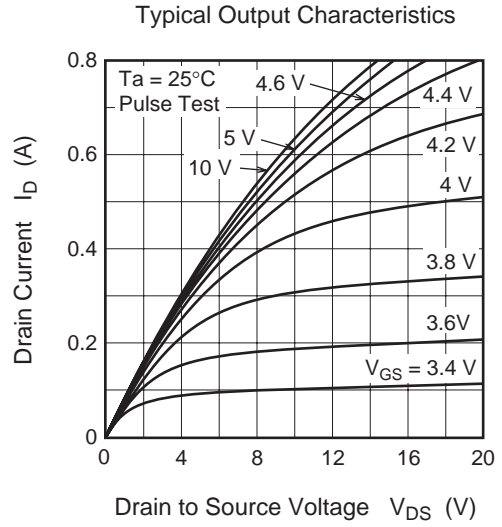
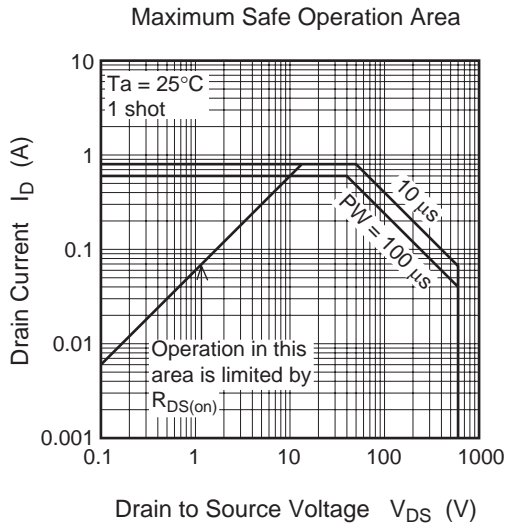
(Ta = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	600	—	—	V	$I_D = 10 \text{ mA}$, $V_{GS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	1	μA	$V_{DS} = 600 \text{ V}$, $V_{GS} = 0$
Gate to source leak current	I_{GSS}	—	—	± 0.1	μA	$V_{GS} = \pm 30 \text{ V}$, $V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	3	—	5	V	$V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$
Static drain to source on state resistance	$R_{DS(on)}$	—	13.5	16.5	Ω	$I_D = 0.1 \text{ A}$, $V_{GS} = 10 \text{ V}$ ^{Note2}
Input capacitance	C_{iss}	—	66	—	pF	$V_{DS} = 25 \text{ V}$
Output capacitance	C_{oss}	—	8.7	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	1.3	—	pF	$f = 1 \text{ MHz}$
Turn-on delay time	$t_{d(on)}$	—	30	—	ns	$I_D = 0.1 \text{ A}$
Rise time	t_r	—	15	—	ns	$V_{GS} = 10 \text{ V}$
Turn-off delay time	$t_{d(off)}$	—	51	—	ns	$R_L = 3000 \Omega$
Fall time	t_f	—	175	—	ns	$R_g = 10 \Omega$
Total gate charge	Q_g	—	4.8	—	nC	$V_{DD} = 480 \text{ V}$
Gate to source charge	Q_{gs}	—	0.6	—	nC	$V_{GS} = 10 \text{ V}$
Gate to drain charge	Q_{gd}	—	3.2	—	nC	$I_D = 0.2 \text{ A}$
Body-drain diode forward voltage	V_{DF}	—	0.77	1.30	V	$I_F = 0.2 \text{ A}$, $V_{GS} = 0$ ^{Note2}
Body-drain diode reverse recovery time	t_{rr}	—	220	—	ns	$I_F = 0.2 \text{ A}$, $V_{GS} = 0$ $di_F/dt = 50 \text{ A}/\mu\text{s}$

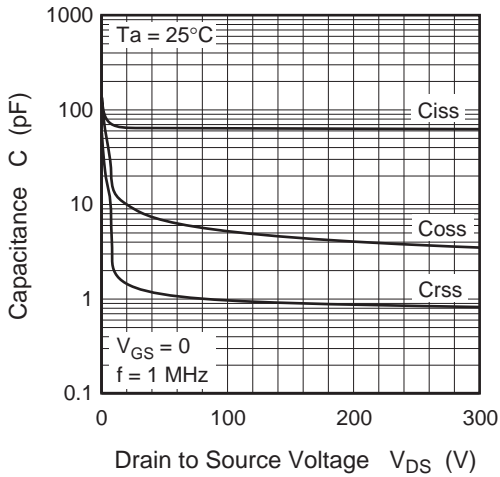
Notes: 2. Pulse test

3. Since this device is equipped with high voltage FET chip ($V_{DSS} \geq 600 \text{ V}$), high voltage may be supplied. Therefore, please be sure to confirm about Electric discharge between Drain terminal and other terminal.
4. This device is sensitive to electrostatic discharge.
It is recommended to adopt appropriate cautions when handling this product.

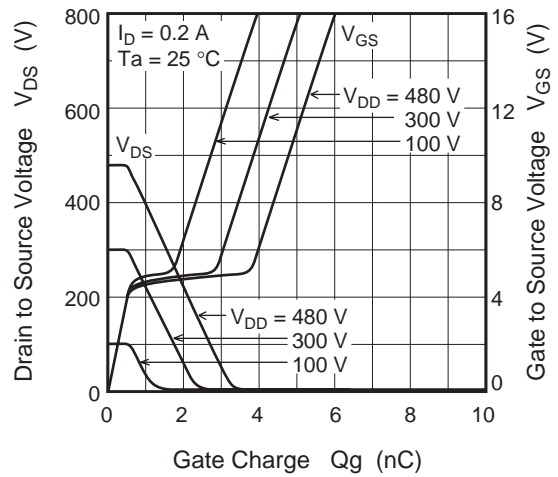
Main Characteristics



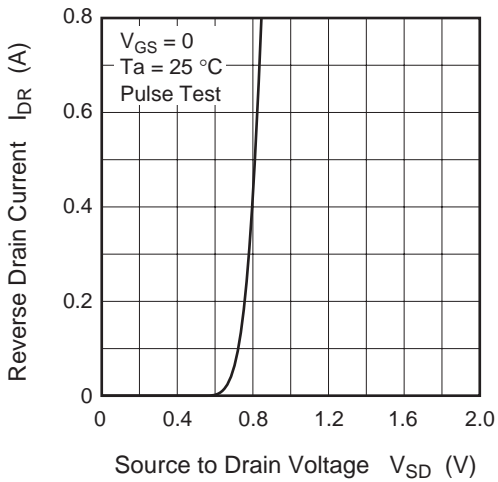
Typical Capacitance vs. Drain to Source Voltage



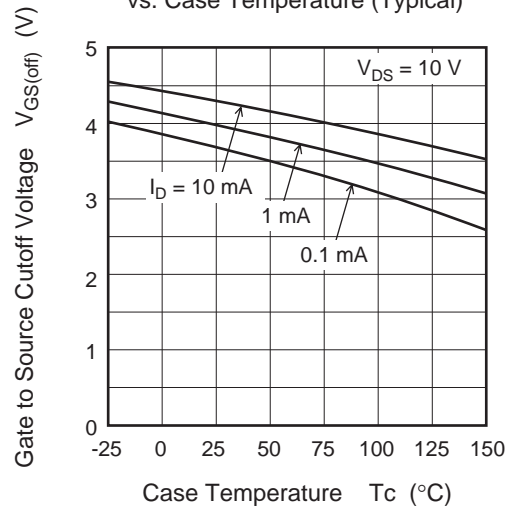
Dynamic Input Characteristics (Typical)

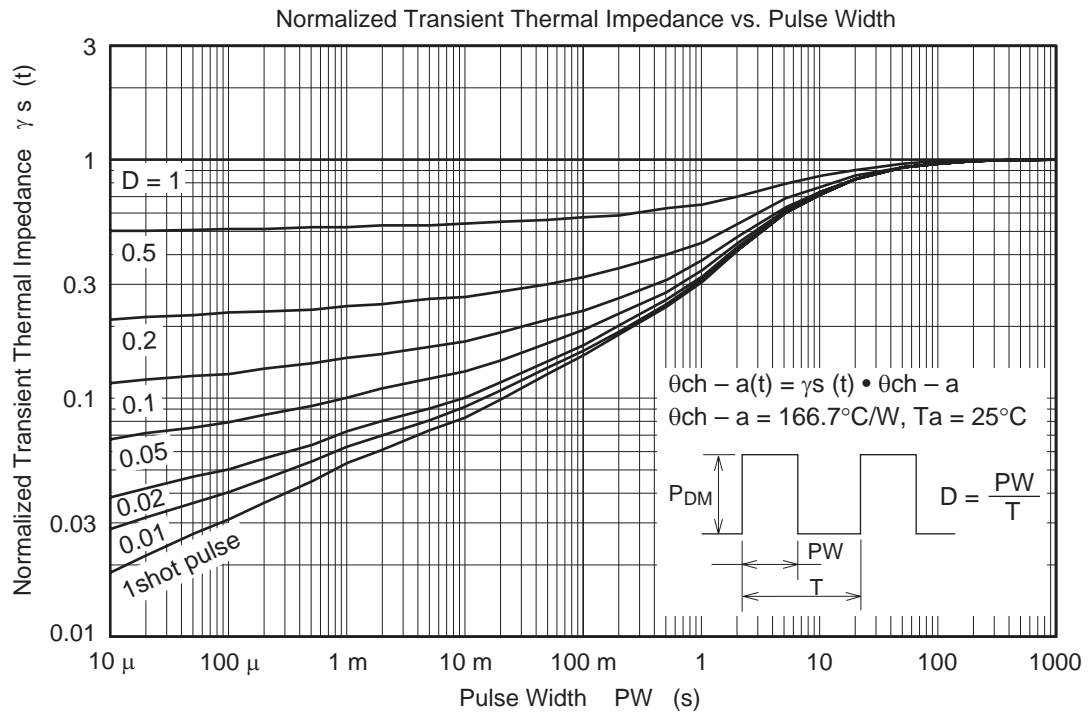


Reverse Drain Current vs. Source to Drain Voltage (Typical)

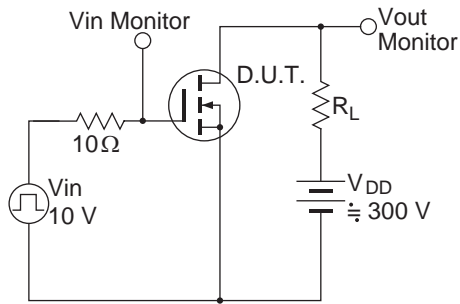


Gate to Source Cutoff Voltage vs. Case Temperature (Typical)

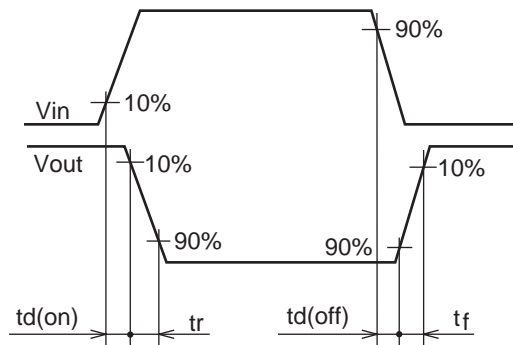




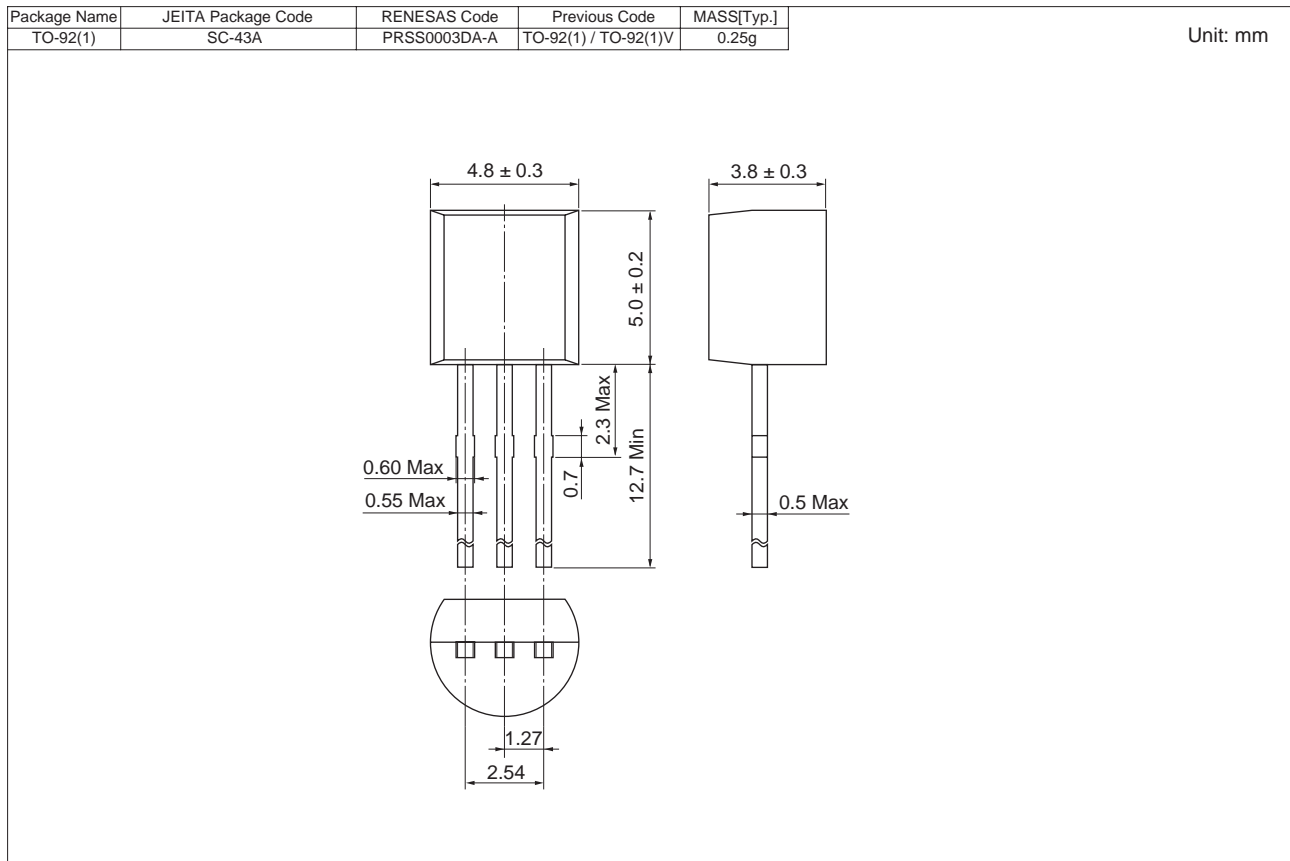
Switching Time Test Circuit



Waveform



Package Dimensions



Since HS54095 is equipped with high voltage FET chip ($V_{DSS} \geq 600$ V), high voltage may be supplied. Therefore, please be sure to confirm about Electric discharge between Drain terminal and other terminal.

Ordering Information

Part No.	Quantity	Shipping Container
HS54095TZ-E	2500 pcs	Hold Box, Radial Taping

Note: Leads is forming applied as following figure.

